

<b>Notice of References Cited</b>	Application/Control No. 09/986,004	Applicant(s)/Patent Under Reexamination MATSUMOTO ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0110989	08-2002	Yamaguchi et al.	438/311
	B	US-2003/0206472	11-2003	Hidaka et al.	365/205
	C	US-			
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	L	US-			
	M	US-			

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*	N	DE 199 62053	07-2000	Germany	Yamaguchi et al	
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**NON-PATENT DOCUMENTS**

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